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International Journal on Advances in Systems and Measurements Volume 3, Numbers 1 & 2, 2010

CONTENTS	
SoC yield Improvement	1 -10
Julien Vial, Université de Montpellier II / CNRS, France	
Arnaud Virazel, Université de Montpellier II / CNRS, France	
Alberto Bosio, Université de Montpellier II / CNRS, France	
Luigi Dilillo, Université de Montpellier II / CNRS, France	
Patrick Girard, Université de Montpellier II / CNRS, France	
Serge Pravossoudovtich, Université de Montpellier II / CNRS, France	
Numerical studies of the metamodel fitting and validation processes	11 - 21
Bertrand looss, Electricité de France - EDF R&D, France	
Loïc Boussouf, Altran, France	
Vincent Feuillard, EADS IW, France	
Amandine Marrel, Institut Français du Pétrole, France	
Single and Multiple Antenna Relay-Assisted Techniques for Uplink and Downlink OFDM	22 - 34
Systems	
Andreia Moco, Aveiro University, Portugal	
Sara Teodoro, Aveiro University, Portugal	
Adao Silva, Aveiro University, Portugal	
Hugo Lima, Aveiro University, Portugal	
Atilio Gameiro, Aveiro University, Portugal	
Flow Time Prediction for a Single-Server Order Picking Workstation using Aggregate	35 - 47
Process Times	
R. Andriansyah, Eindhoven University of Technology, The Netherlands	
L. F. P. Etman, Eindhoven University of Technology, The Netherlands	
J. E. Rooda, Eindhoven University of Technology, The Netherlands	
Two-Level Validation and Data Acquisition for Microscopic Traffic Simulation Models	48 - 56
Stefan Detering, Technische Universität Braunschweig, Germany	
Lars Schnieder, Technische Universität Braunschweig, Germany	
Eckehard Schnieder, Technische Universität Braunschweig, Germany	
A Shape Grammar with Feedback Generative Model for the Design of Compact	57 - 70
Microstrip Antennas	
Adrian Muscat, University of Malta, Malta	
The Two-dimensional Superscalar GAP Processor Architecture	71 - 81

71 - 81

Sascha Uhrig, University of Augsburg, Germany Basher Shehan, University of Augsburg, Germany Ralf Jahr, University of Augsburg, Germany Theo Ungerer, University of Augsburg, Germany

Neuro-PID Control of Speed and Torque of Electric Vehicle

Sigeru Omatu, Osaka Prefecture University, Japan Michifumi Yoshioka, Osaka Prefecture University Toshihisa Kosaka, Osaka Prefecture University Hidekazu Yanagimoto, Osaka Prefecture University Jamal Ahamad Dargham, University of Malaysia Sabah, Malaysia 82 - 91